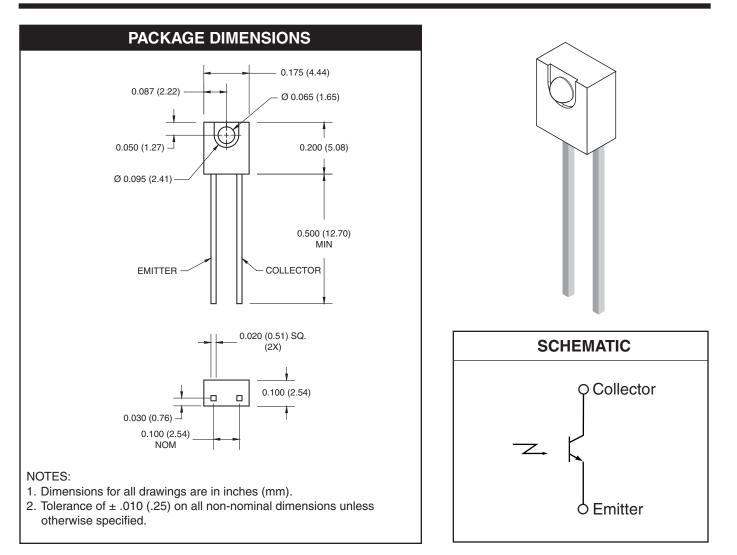


PLASTIC SILICON INFRARED PHOTOTRANSISTOR

QSE113 QSE114



DESCRIPTION

The QSE113/114 is a silicon phototransistor encapsulated in a wide angle, infrared transparent, black plastic sidelooker package.

FEATURES

- NPN silicon phototransistor
- Package type: Sidelooker
- Medium wide reception angle, 50°
- · Package material and color: black epoxy
- Matched emitter: QEE113
- Daylight filter
- High sensitivity



SEMICONDUCTOR®

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QSE113 QSE114

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^{\circ}C$ unless otherwise specified)							
Parameter	Symbol	Rating	Unit				
Operating Temperature	T _{OPR}	-40 to +100	°C				
Storage Temperature	T _{STG}	-40 to +100	°C				
Soldering Temperature (Iron) ^(2,3,4)	T _{SOL-I}	240 for 5 sec	°C				
Soldering Temperature (Flow) ^(2,3)	T _{SOL-F}	260 for 10 sec	°C				
Collector Emitter Voltage	V _{CE}	30	V				
Emitter Collector Voltage	V _{EC}	5	V				
Power Dissipation ⁽¹⁾	PD	100	mW				

NOTES:

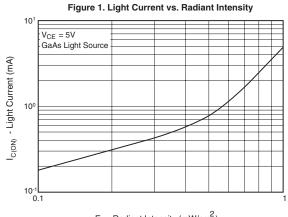
- 1. Derate power dissipation linearly 1.33 mW/°C above 25°C.
- 2. RMA flux is recommended.
- 3. Methanol or isopropyl alcohols are recommended as cleaning agents.
- 4. Soldering iron 1/16" (1.6 mm) minimum from housing.
- 5. $\lambda = 880$ nm (AlGaAs).

ELECTRICAL / OPTICAL CHARACTERISTICS (T _A =25°C unless otherwise specified)								
Parameter	Test Conditions	Symbol	Min	Тур	Max	Units		
Peak Sensitivity		λ _{PS}		880	_	nM		
Reception Angle		Θ	_	±25	_	Deg.		
Collector Emitter Dark Current	V _{CE} = 10 V, E _e = 0	I _{CEO}		_	100	nA		
Collector-Emitter Breakdown	I _C = 1 mA	BV _{CEO}	30	—	—	V		
Emitter-Collector Breakdown	I _E = 100 μA	BV _{ECO}	5	_	—	V		
On-State Collector Current ⁽⁵⁾ QSE113	$E_{e} = 0.5 \text{ mW/cm}^{2}, V_{CE} = 5 \text{ V}$	I _{C(ON)}	0.25	_	1.50	mA		
On-State Collector Current ⁽⁵⁾ QSE114	$E_{e} = 0.5 \text{ mW/cm}^{2}, V_{CE} = 5 \text{ V}$	I _{C(ON)}	1.00	_	_	mA		
Saturation Voltage ⁽⁵⁾	$E_e = 0.5 \text{ mW/cm}^2$, $I_C = 0.1 \text{ mA}$	V _{CE(SAT)}	_	—	0.4	V		
Rise Time	$I_{C} = 1$ mA, $V_{CC} = 5$ V, $R_{L} = 100\Omega$	t _r		8	_	μs		
Fall Time		t _f		8	—	μs		



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E_e - Radiant Intensity (mW/cm²)

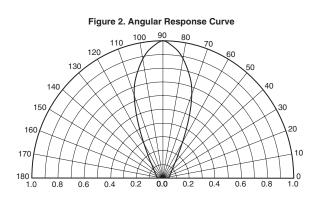


Figure 3. Dark Current vs. Collector - Emitter Voltage

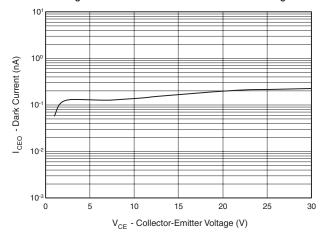
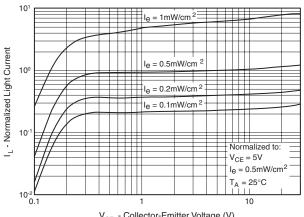


Figure 4. Light Current vs. Collector - Emitter Voltage



V_{CE} - Collector-Emitter Voltage (V)

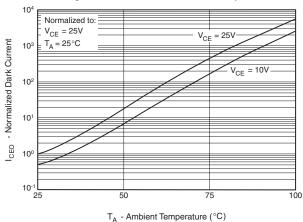


Figure 5. Dark Current vs. Ambient Temperature



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